

# Model AE-365E Ultra high speed & high accuracy 120Hz/1kHz Digital Capacitor Checker

Most suitable model for inspection on taping machine of "CHIP", "MELF", "RADIAL" and "AXIAL" Capacitor

### Characteristic

- ■Ultra high speed: 1msec. [TYP] (Measurement time)
- Measurement stability of the minute capacity largely improvably 2pF/5V and 20pF/5V range addition.
- It is poor contact detection of the probe at the time of 2 terminal (4 terminals) measurement by measurement abnormality detection.
- ■4 terminals contact check: After measurement/ OFF is selectable
- Measurement frequency: 1kHz/120Hz±0.1%(a sine wave)
- Change possibility of series equivalent circuit/parallel equivalent circuit.
- Available to measure by constant voltage for the capacitor with the voltage dependence. (It is not supported some range)
- $\blacksquare$  Available Tan  $\delta$  measurement (It is not supported 2 pF range)
- ■3<sup>1</sup>/₂figures(1999) display and available HI/GO/LO judgment by comparator
- "RS-232C" and "printer output" function (Centronics conformity) are as normal. ("GP-IB" is option)
- Supplies a measurement electric current by intermittent in order to reduce the abrasion of the probe contact.  $[120 \,\mu\,\text{F}/1.2\text{mF}]$





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## **SPECIFICATIONS**

#### Measurning range and Accuracy (D<0.1 Ambient temperature 23°C±5°C)

Range	Measuring range	Resolution	Accuracy	Measurement voltage	
2pF	0.000pF∼1.999pF	0.001pF	Within ±1.0% of rdg±5digit×α		1kHz.5V±5%[rms]
20pF	0.00pF∼19.99pF	0.01pF	Within ±0.25% of rdg±3digit×α		1KH2(01 = 0%[1 mo]
200pF	0.0pF∼199.9pF	0.1pF	Within ±0.2% of rdg±2digit×α	1kHz、1V±5%[rms]	
2nF	0.000nF~1.999nF	0. 001nF	Within ±0.2% of rdg±2digit		
20nF	0. 00nF~19. 99nF	0. 01nF			
200nF	0. 0nF∼199. 9nF	0. 1nF			
2µF	0. 000μF∼1. 999μF	0. 001µF			10011 0 511 5115 7
20µF	0. 00μF∼19. 99μF	0.01µF	Within ±0.3% of rdg±3digit×α		120Hz、0.5V±5%[rms]
120µF	0. 0μF~119. 9μF	0.1µF	Within ±1.0% of rdg±5digit×α	1kHz、1V+5%~-15%[rms]	
200µF	0. 0μF~199. 9μF	0.1µF	Within ±0.5% of rdg±3digit×α		120Hz、0.5V±5%[rms]
1. 2mF	0.000mF~1.199mF	0.001mF	Within ±1.5% of rdg±5digit×α		120Hz、0.5V+5%∼−25%[rms]

 $\times$ In case of 0.1<D<1, 25D/100(%) is added on the above accuracy.

lpha : In case of FAST 2(In case of 2pF Range/1 V lpha=10) In case of SLOW 1(In case of 2pF Range/1 V lpha=5)

Measurement Method	3/5 terminal measurement [Available to select the measuring method on each range]		
Measuring Frequency	$120$ Hz $/1$ kHz $\pm0.1\%$ , sine wave		
Output Impedance	Approx. 1 Ω		
Straycapacity revision range	Approx. 30pF		
temperature coefficient	Within ±100ppm/°C[f.s and zero]		
Measurement time	[Free running]FAST: Aprrox.1∼5 time/sec. SLOW: FAST × N(N: The setting number of "average")		
	[Start trigger signal [FAST]]1msec.[Fastest time]		
Comparator set range	Capacitance: 1999[120μF/1.2mF range: 1199] with HI and LO limit tanδ: 99.9%		
Use environment	Temperature:0°C∼+50°C、 Humidity:Less than 85%		
Power supply	AC85V~265V, 50~60Hz, Aprrox. 50VA		
Outer dimension	333(W) × 99(H) × 300(D)mm		
Weight	Approx. 4kg		

\* We will change the specifications of the catalogue without notice by improvement.

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